

**Search Notes****Application/Control No.**

10/828,888

**Examiner**

A. Dexter Tugbang

**Applicant(s)/Patent under Reexamination**

GUAN ET AL.

**Art Unit**

3729

**SEARCHED**

Class	Subclass	Date	Examiner
29	603.07 603.08 603.11 603.14 603.2	4/2/2007	ADT
	604		
360	119		
	120 122		
	125 126		
	313	↓	↓

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Search: NPL (IEEE Xplore Database)	4/2/2007	ADT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner